- The grain size is often determined when the properties of polycrystalline and single-phase materials are under consideration.
- Grain size may be specified in terms of average or mean grain diameter, and a number of techniques have been developed to measure this parameter.
- Before the advent of the digital age, grain-size determinations were performed manually using photomicrographs. Two common grain-size determination techniques: (1) Linear intercept counting numbers of grain boundary intersections by straight test lines; and (2) Comparison comparing grain structures with standardized charts, which are based upon grain areas.

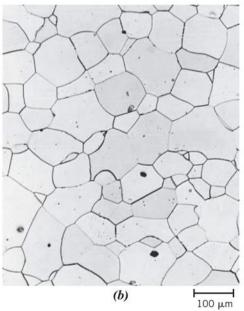
- For the linear intercept method, lines are drawn randomly through several photomicrographs that show the grain structure (all taken at the same magnification).
- Grain boundaries intersected by all the line segments are counted. Let us represent the total length of all the lines by L_T and the sum of the total number of intersections as P. The mean intercept length ℓ (bar), a measure of grain diameter, may be determined by the following expression:

$$\bar{\ell} = \frac{L_T}{PM}$$

where *M* is the magnification

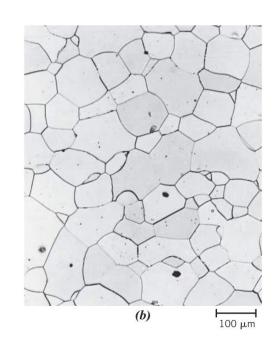
- To compute magnification from a scale bar, the following procedure may be used:
 - 1. Measure the length of the scale bar in millimeters using a ruler.
 - 2.Convert this length into microns [i.e., multiply the value in step (1) by 1000 because there are 1000 microns in a millimeter].
 - 3. Magnification M is equal to

$$M = \frac{\text{measured scale length (converted to microns)}}{\text{the number appearing by the scale bar (in microns)}}$$



- The measured scale length is approximately 10 mm, which is equivalent to (10 mm)(1000 $\mu m/mm = 10,000 \mu m.$
- The scale bar length is 100 µm, magnification is equal to

$$M = \frac{10,000 \,\mu\text{m}}{100 \,\mu\text{m}} = 100 \times$$



• The magnification is specified in the micrograph legend (e.g., "60×"); this means the micrograph represents a 60 times enlargement of the specimen in real space.

• The comparison method of grain-size determination was devised by the American Society for Testing and Materials (ASTM).

• Relationships have been developed that relate mean intercept length to ASTM grain-size number (G); these are as follows:

$$G = -6.6457 \log \overline{\ell} - 3.298$$
 (for $\overline{\ell}$ in mm)
 $G = -6.6353 \log \overline{\ell} - 12.6$ (for $\overline{\ell}$ in in.)

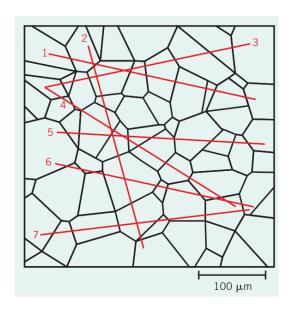
Q. The following is a schematic micrograph

that represents the microstructure of some

hypothetical metal. Determine the following:



(b) ASTM grain-size number, G



• Let G represent the grain-size number, and let n be the average number of grains per square inch at a magnification of 100×. These two parameters are related to each other through the expression:

$$n = 2^{G-1}$$

• For photomicrographs taken at magnifications other than 100×, use of the following modified form of Equation is necessary:

$$n_M \left(\frac{M}{100}\right)^2 = 2^{G-1}$$